COMPLIANT HALOGEN

FREE



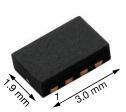
www.vishay.com

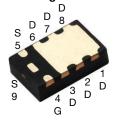
Vishay Siliconix

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω) MAX.	I _D (A) ^a	Q _g (TYP.)		
	0.0064 at V _{GS} = 10 V	25			
30	0.0070 at V _{GS} = 6 V	25	11.5 nC		
	0.0085 at V _{GS} = 4.5 V	25			

PowerPAK® ChipFET® Single





p View Bottom View

Marking Code: AR
Ordering Information:

Si5446DU-T1-GE3 (lead (Pb)-free and halogen-free)

FEATURES

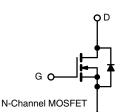
- TrenchFET® power MOSFET
- Thermally enhanced PowerPAK® ChipFET® package



- Low on-resistance
- Thin 0.8 mm profile
- 100 % R_a tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Mobile computing / tablet PCs
- DC/DC converters
- Synchronous buck converters
- Power management



ABSOLUTE MAXIMUM RATING	S $(T_A = 25 ^{\circ}C, U)$	ınless otherv	vise noted)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V _{GS}	+20 / -16	v	
	T _C = 25 °C		25 ^a		
Continuous Dunin Commant /T. 150 °C)	T _C = 70 °C	1 . [25 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	12.4 ^{b, c}		
	T _A = 70 °C	1 [9.9 ^b ,c	А	
Pulsed Drain Current (t = 100 μs)		I _{DM}	60		
	T _C = 25 °C		25 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	l _S	2.6 ^{b, c}		
	T _C = 25 °C		31		
Maniana Danian Disabatian	T _C = 70 °C] [20	14/	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.1 ^{b,c}	W	
	T _A = 70 °C	1	2 ^{b,c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150		
Soldering Recommendations (Peak Temperature) d, e			260	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum Junction-to-Ambient b, f	t ≤ 5 s	R _{thJA}	34	40	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3	4	C/VV	

Notes

a. Package limited.

S15-2604-Rev. C, 09-Nov-15

- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile (<u>www.vishay.com/doc?73257</u>). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 90 °C/W.



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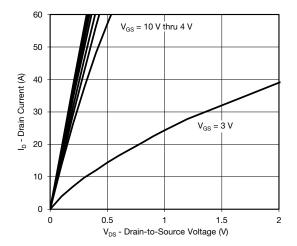
SPECIFICATIONS ($T_J = 25 ^{\circ}\text{C}$, u		,	BAINI	TVD	MAN	TUALL	
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static	l v, l	V 0V 1 050 A	30	1	I	l ,,	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		-	-	V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA	-	15	-	mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	- ,	-	-6	-		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1	-	2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V} / -16 \text{ V}$	-	-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μA	
	.033	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	-	-	10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30	-	-	Α	
		$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	-	0.0054	0.0064		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 6 \text{ V}, I_D = 8 \text{ A}$	-	0.0058	0.0070	Ω	
		$V_{GS} = 4.5 \text{ V}, I_D = 6 \text{ A}$	-	0.0068	0.0085		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_D = 8 \text{ A}$	-	65	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}		-	1990	-		
Output Capacitance	C _{oss}	V 45VV 0V (4 MI)	-	550	-	рF	
Reverse Transfer Capacitance	C _{rss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	60	-		
C _{rss} /C _{iss} Ratio			-	0.03	0.06		
		V _{DS} = 15 V, V _{GS} = 10 V, I _D = 18 A	-	25.2	38		
Total Gate Charge	Qg		-	11.5	20		
Gate-Source Charge	Q _{as}	Q _{gs}	-	5.1	-	nC	
Gate-Drain Charge	Q _{gd}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$	_	1.7	-		
Output Charge	Q _{oss}		-	14.5	-		
Gate Resistance	Rg	f = 1 MHz	0.2	1	2	Ω	
Turn-on Delay Time	t _{d(on)}		-	8	16		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{I} = 1.5 \Omega$	-	25	40	- -	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_q = 1 \Omega$	_	16	30		
Fall Time	t _f	Ç .	_	8	16		
Turn-On Delay Time	t _{d(on)}		-	17	30	ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{I} = 1.5 \Omega$	_	62	95	- - -	
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = 15 \text{ V}, \text{ N}_{L} = 1.5 \Omega$ $I_{D} \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, \text{ R}_{q} = 1 \Omega$	-	16	30		
Fall Time	t _f		_	12	20		
Drain-Source Body Diode Characteristic						l	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	_	_	25		
Pulse Diode Forward Current (t = 100 μs)	I _{SM}	10 - 20 0	_	_	60	Α	
Body Diode Voltage	V _{SD}	I _S = 10 A, V _{GS} = 0 V	_	0.85	1.2	V	
Body Diode Voltage Body Diode Reverse Recovery Time		15 - 10 A, VGS - U V	-	37	-	ns	
Body Diode Reverse Recovery Charge	t _{rr}		-	37	60	nC	
	Q _{rr}	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-		00	110	
Reverse Recovery Fall Time	t _a		-	20	-	ns	
Reverse Recovery Rise Time	t _b		-	17	-	1	

Notes

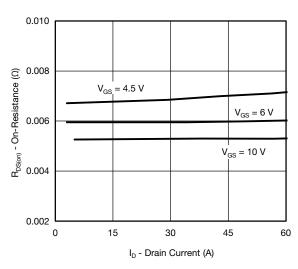
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

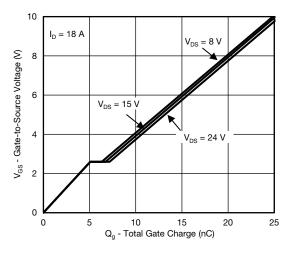




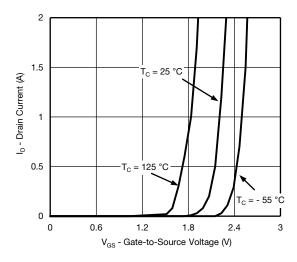
Output Characteristics



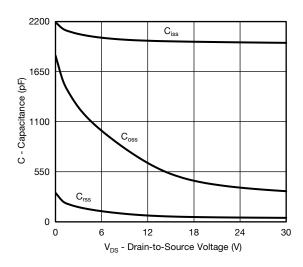
On-Resistance vs. Drain Current and Gate Voltage



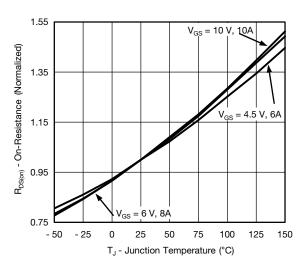
Gate Charge



Transfer Characteristics

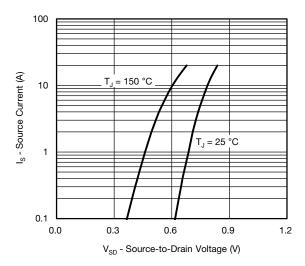


Capacitance

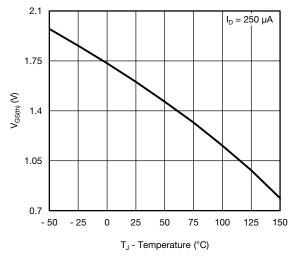


On-Resistance vs. Junction Temperature

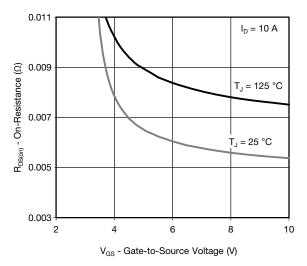




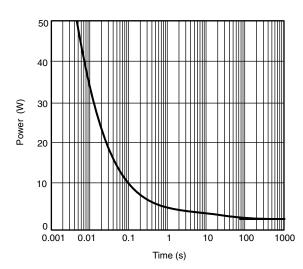
Source-Drain Diode Forward Voltage



Threshold Voltage

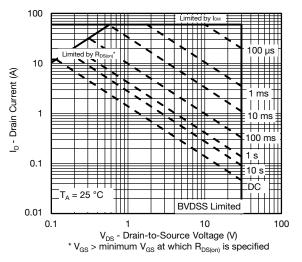


On-Resistance vs. Gate-to-Source Voltage

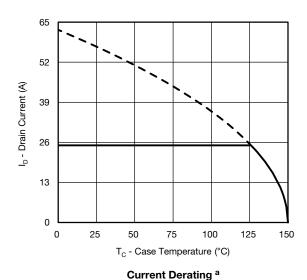


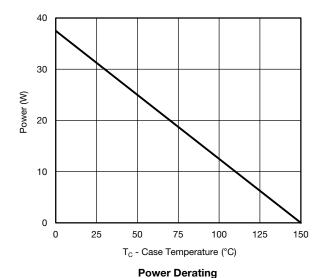
Single Pulse Power, Junction-to-Ambient





Safe Operating Area, Junction-to-Ambient

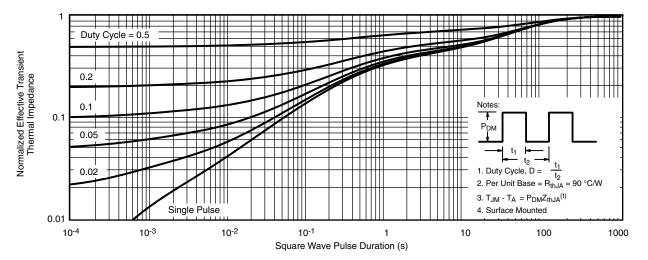




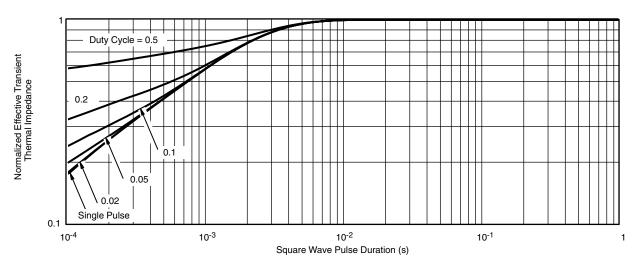
Note

a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

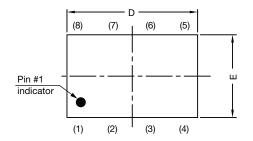


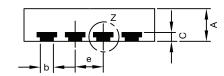
Normalized Thermal Transient Impedance, Junction-to-Case

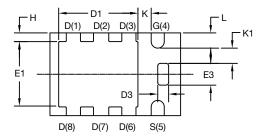
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?62931.



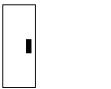
PowerPAK® ChipFET® Case Outline







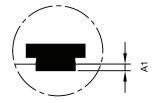
Backside view of single pad



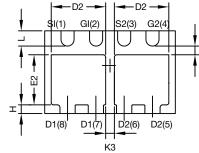
Side view of single



Side view of dual



Detail Z



Backside view of dual pad

DIM.		MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
Α	0.70	0.75	0.85	0.028	0.030	0.033		
A1	0	-	0.05	0	-	0.002		
b	0.25	0.30	0.35	0.010	0.012	0.014		
С	0.15	0.20	0.25	0.006	0.008	0.010		
D	2.92	3.00	3.08	0.115	0.118	0.121		
D1	1.75	1.87	2.00	0.069	0.074	0.079		
D2	1.07	1.20	1.32	0.042	0.047	0.052		
D3	0.20	0.25	0.30	0.008	0.010	0.012		
Е	1.82	1.90	1.98	0.072	0.075	0.078		
E1	1.38	1.50	1.63	0.054	0.059	0.064		
E2	0.92	1.05	1.17	0.036	0.041	0.046		
E3	0.45	0.50	0.55	0.018	0.020	0.022		
е		0.65 BSC			0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010		
K	0.25	-	-	0.010	-	-		
K1	0.30	-	-	0.012	-	-		
K2	0.20	-	-	0.008	-	-		
K3	0.20	-	-	0.008	-	-		
L	0.30	0.35	0.40	0.012	0.014	0.016		

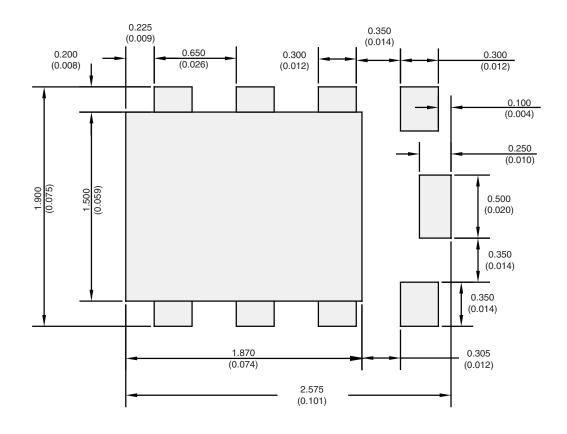
Note

DWG: 5940

• Millimeters will govern



RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE



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